

Excellent Integrated System Limited

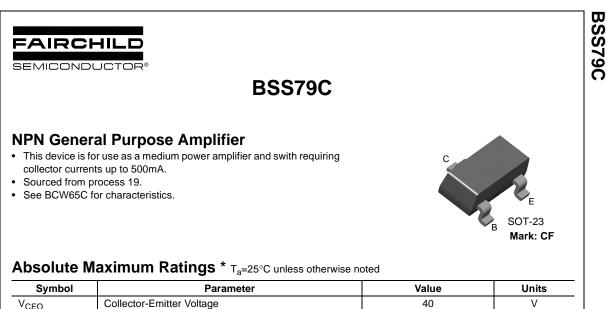
Stocking Distributor

Click to view price, real time Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor BSS79C

For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>





V _{CEO}	Collector-Emitter Voltage	40	V
V _{CBO}	Collector-Base Voltage	75	V
V _{EBO}	Emitter-Base Voltage	6.0	V
I _C	Collector Current - Continuous	800	mA
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 ~ +150	°C
* These ratings are lim	ting values above which the serviceability of any semiconductor device may be	impaired.	

NOTES:

These ratings are based on a maximum junction temperature of 150 degrees C.
These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Electrical Characteristics Ta=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
Off Charac	teristics	·			
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage	$I_{\rm C} = 10 {\rm mA}, I_{\rm B} = 0$	75		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = 10 \mu {\rm A}, I_{\rm E} = 0$	40		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_{\rm E} = 10\mu A, I_{\rm C} = 0$	6.0		V
I _{CBO}	Collector-Cutoff Current	$V_{CB} = 60V$ $V_{CB} = 60V, T_a = 150^{\circ}C$		10 10	nA μA
I _{EBO}	Emitter-Cutoff Current	$V_{EB} = 3.0V, I_{C} = 0$		10	nA
On Charac	teristics *	·			
h _{FE}	DC Current Gain	I _C = 150mA, V _{CE} = 10V	100	300	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_{C} = 150$ mA, $I_{B} = 15$ mA $I_{C} = 500$ mA, $I_{B} = 50$ mA		0.3 1.0	V V
Small Sigr	al Characteristics	·	•		
f _T	Current Gain - Bandwidth Product	I _C = 20mA, V _{CE} = 20V, f = 100MHz		250	MHz
C _{CB}	Collector-Base Capacitance	V _{CB} = 10V, I _E = 0, f = 1.0MHz		8.0	pF
Switching	Characteristics	-			
t _d	Delay Time	$V_{CC} = 30V, V_{BE(OFF)} = 0.5V,$		10	ns
t _r	Rise Time	I _C = 150mA, I _{B1} = 15mA		10	ns
t _s	Storage Time	V _{CC} = 30V, I _C = 150mA,		265	ns
t _f	Fall Time	$I_{B1} = I_{B2} = 15 \text{mA}$		60	ns

©2004 Fairchild Semiconductor Corporation

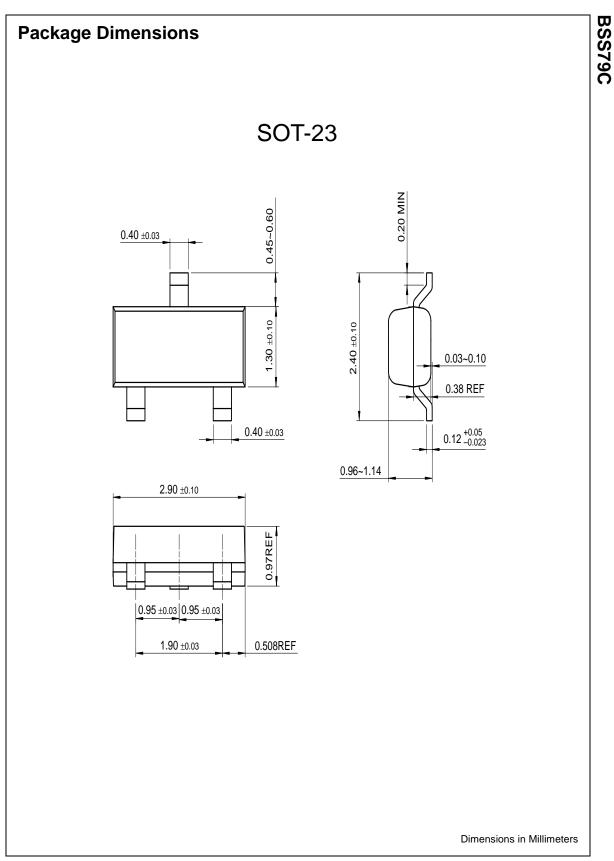


b Total Device Dissipation 350 mW//C Aut Thermal Resistance, Junction to Ambient 357 °C/W evec mounted or R44 PG8 400m × 40mm × 1.5mm 357 °C/W ************************************	Symbol	Parameter	Max.	Units
		Total Device Dissipation	350	mW
type in the main resistance, Junction to Antolem 1 (2007) (2007) wide mounted on PR-4 PCB 400mm × 40mm × 1.5mm	`			
	Nevice mounted (n FR-4 PCB 400mm × 40mm × 1.5mm	557	C/W

©2004 Fairchild Semiconductor Corporation

Rev. A, June 2004





©2004 Fairchild Semiconductor Corporation

Rev. A, June 2004



0	gistered and unregistered tr chaustive list of all such trad		onductor owns or is authori	ized to use and is r
ACEx™	FAST [®]	ISOPLANAR™	Power247™	SuperFET™
ActiveArray™	FASTr™	LittleFET™	PowerSaver™	SuperSOT™-3
Bottomless™	FPS™	MICROCOUPLER™	PowerTrench [®]	SuperSOT™-6
CoolFET™	FRFET™	MicroFET™	QFET [®]	SuperSOT™-8
CROSSVOLT™	GlobalOptoisolator™	MicroPak™	QS™	SyncFET™
DOME™	GTO™	MICROWIRE™	QT Optoelectronics™	TinyLogic®
EcoSPARK™	HiSeC™	MSX™	Quiet Series™	TINYOPTO™
E ² CMOS™	I ² C™	MSXPro™	RapidConfigure™	TruTranslation [⊤]
EnSigna™	<i>i-Lo</i> ™	OCX™	RapidConnect™	UHC™
FACT™	ImpliedDisconnect™	OCXPro™	μSerDes™	UltraFET [®]
FACT Quiet Series	тм	OPTOLOGIC [®]	SILENT SWITCHER®	VCX™
Across the board. Around the world.™		OPTOPLANAR™	SMART START™	
The Power Franchise [®]		PACMAN™	SPM™	
Programmable Act		POP™	Stealth™	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

©2004 Fairchild Semiconductor Corporation